Proposal of X-ray absorption spectroscopy and magnetic circular dichroism using broadband free-electron lasers

Bangjie Deng,[a] Jiawei Yan,[b,c] Qingmin Zhang,[a]* Yaodong Sang[a] and Haixiao Deng[b]*

[a]School of Nuclear Science and Technology, Xi'an Jiaotong University, Xi'an, Shaanxi 710049, People's Republic of China, [b]Shanghai Institute of Applied Physics, Chinese Academy of Sciences, Shanghai 201800, People's Republic of China, and [c]University of Chinese Academy of Sciences, Beijing 100049, People's Republic of China. *Correspondence e-mail: zhangqingmin@mail.xjtu.edu.cn, denghaixiao@sinap.ac.cn

X-ray free-electron lasers (XFELs) have been widely used for applications such as X-ray crystallography and magnetic spin probes because of their unprecedented performance. Recently, time-resolved X-ray magnetic circular dichroism (XMCD) with ultrafast XFEL pulses have made it possible to achieve an instantaneous view of atomic de-excitation. However, owing to the narrow bandwidth and coherence of XFELs, X-ray absorption spectroscopy (XAS) and XMCD are time- and effort-consuming for both machine scientists and users of XFELs. In this work, an efficient scheme using a broadband XFEL pulse and single-shot X-ray spectrometer is proposed, in which the XAS and XMCD measurements can be accomplished with the same machine conditions. An evolutionary multi-objective optimization algorithm is used to maximize the XFEL bandwidth offered by the Shanghai Soft X-ray FEL user facility without additional hardware. A numerical example using MnO is demonstrated, showing that, by using approximately 1000 consecutive XFEL shots with a central photon energy of 650 eV and full bandwidth of 4.4%, precise spectral measurements for XAS and XMCD can be achieved. Additional considerations related to single-shot XAS and XMCD are discussed.

1. Introduction

X-ray absorption spectroscopy (XAS) and X-ray magnetic circular dichroism (XMCD) with coherent light sources are two popular techniques used at the frontiers of materials science because they can probe element-specific electric and magnetic properties (Stöhr, 1992, 1999; Singhal *et al.*, 2010). Currently, synchrotron radiation is the leading available X-ray source for XAS and XMCD experiments; however, limited photons and inadequate temporal resolution of individual X-ray pulses do not support ultrafast dynamics and spintronics (Radu *et al.*, 2011). Although high-harmonic generation from rare gas is suitable for time-resolved experiments, significant challenges remain in enhancing the pulse energy and stability of such X-ray sources (Popmintchev *et al.*, 2012; Fleischer *et al.*, 2014).

Owing to ultrafast pulse duration, well defined polarization and high brightness (Emma *et al.*, 2010; Allaria *et al.*, 2014), X-ray free-electron lasers (XFELs) are the most appealing light source for time-resolved XAS/XMCD experiments that capture instantaneous microscopic activity. Usually, the relative bandwidth of an XFEL is approximately 0.1%, even in self-amplified spontaneous emission (SASE) modes (Bonifacio *et al.*, 1984), which is not large enough to cover the entire
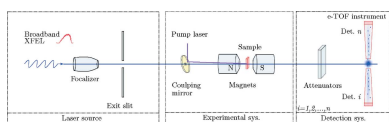
XAS/XMCD spectra in one pulse. In the first time-resolved XAS/XMCD experiment using an XFEL (Higley *et al.*, 2016), a narrow-bandwidth XFEL was used to scan the entire XAS/XMCD spectra within an energy band of 40 eV, which contrasts with the 0.1–0.2 eV typically covered with one XFEL shot after a grating monochromator. Time- and effort-consuming machine controls are necessary, such as the undulator gap tuning, beam orbit maintenance and monochromator adjustment. Compared with synchrotron radiation light sources, limited experimental stations can be constructed for an XFEL facility. Therefore, such conventional methods cannot be widely used in the XAS/XMCD experiments due to their low operational efficiency.

In addition to pursuing narrow-bandwidth FEL pulses, the large-bandwidth operation mode of XFELs has been proposed in recent years (Song *et al.*, 2018; Hernandez *et al.*, 2016; Serkez *et al.*, 2013; Zagorodnov *et al.*, 2016; Prat *et al.*, 2016; Turner *et al.*, 2014). Because one broadband XFEL pulse covers the entire energy range of absorption spectra and the number of X-ray photons in each pulse reaches 10^{12}, in principle the XAS and XMCD experiments can be accomplished without major interactions with XFEL machine components. In this study, an efficient XAS/XMCD scheme driven by broadband XFEL pulses is proposed. In order to determine satisfactory radiation bandwidths and corresponding operation parameters at the Shanghai Soft X-ray Free-Electron Laser (SXFEL) user facility, an evolutionary multi-objective optimization algorithm is utilized to maximize the FEL bandwidth. A numerical example is defined to demonstrate the XAS and XMCD method driven by broadband XFEL. In conventional XAS and XMCD experiments with monochromatic synchrotron radiation, absorption cross-sections are usually derived by measuring the fluorescence yield (Goedkoop *et al.*, 1997; Lobenstine & Turner, 1980), the current of Auger electrons (Matsui *et al.*, 2010) and the E_{ph} spectrum of the transmitted X-rays (Kotani *et al.*, 2009; Miedema & Groot, 2013; Higley *et al.*, 2016). However, the two former methods are not suitable for spectroscopy experiments with broadband FELs because their measured yields are only related to the flux of the XFEL pulses (Ge *et al.*, 2013; Mathieu, 1985). In addition, the flight time of escaped Auger electrons can be modified by a strong magnetic field during XMCD measurement. In contrast, a method based on a transmission spectrum is practical for the XAS and XMCD experiments with broadband XFEL pulses because the flux and energy spectrum of the broadband XFEL can be obtained. Recently, several such methods have been implemented for absorption spectrum measurements (Bernstein *et al.*, 2009; Higley *et al.*, 2016), including the use of a grating raster for the simultaneous measurement of incident and transmitted E_{ph} spectra (Bernstein *et al.*, 2009). However, in order to monitor the polarization properties of incident or transmitted FEL pulses, in this study an e-TOF-based instrument was chosen because of its ability to simultaneously measure both the XFEL spectrum and polarization (Zhang *et al.*, 2017). In our case, using an SXFEL operated at a 50 Hz repetition rate (Song *et al.*, 2017) and an e-TOF-based high-resolution spectrometer

(Zhang *et al.*, 2017), the absorption spectrum of an MnO sample was measured in 1 min after careful calibration. Therefore, the broadband XFEL offers a more efficient method for both steady-state and time-resolved XAS and XMCD experiments.

This paper is organized as follows. In Section 2, the expectation of broad-bandwidth FEL pulses generation at the SXFEL is studied with an evolutionary multi-objective optimization algorithm, followed by a description of how a broadband XFEL can drive XAS and XMCD, and the details of the proposed experimental procedures are given in Section 3. In Section 4, using MnO as an example, numerical results and a corresponding sensitivity analysis are presented. Further discussion of single-shot XAS and XMCD is given in Section 5. Finally, conclusions are summarized in Section 6.

2. Broadband FEL pulse generation at SXFEL

An evolutionary multi-objective optimization algorithm is used to find the maximum available radiation bandwidth at SXFEL, which is critical for XAS and XMCD experiments. According to the FEL resonance condition (Huang & Kim, 2007),

$$\lambda = \frac{\lambda_{u}}{2\gamma^2}\left(1 + \frac{K^2}{2}\right), \tag{1}$$

where λ is the radiation wavelength, λ_{u} is the undulator period length, γ is the average Lorentz factor of the electrons and K is the undulator field parameter. Two primary methods exist to generate a large-bandwidth FEL. One is to use an energy-chirped electron beam (Emma, 2005; Hernandez *et al.*, 2016; Serkez *et al.*, 2013; Zagorodnov *et al.*, 2016), and the other is to utilize space-field correlations in the undulator, such as by injecting a head-to-tail tilted beam into a transverse gradient undulator (Prat *et al.*, 2016) or a planar undulator (Song *et al.*, 2018). Using a large energy-chirped electron beam is a simple and natural way to generate broadband XFEL radiation. Recently, the use of a special overcompression (Emma, 2005) scheme to generate a large energy chirp has attracted increasing attention (Hernandez *et al.*, 2016; Zagorodnov *et al.*, 2016; Turner *et al.*, 2014). In this scheme, electron beams with energy chirps are overcompressed in a bunch compressor, where the heads and tails of beams exchange their positions, and resulting wakefields from the RF structures further increase the energy chirp.

To overcompress electron bunches, the operating parameters of accelerating sections, linearizer and bunch compressor must be appropriately changed. Optimizing these parameters and determining an affordable XFEL bandwidth are crucial. The optimization goal is to generate electron beams with large energy chirps, high peak currents, good current profiles and reasonable slice energy spreads. Some of these objectives are contradictory, and thus one must explore global optimal solutions that compromise these objectives. Here, a Pareto-dominance-based multiobjective evolutionary algorithm, NSGA-II (DEB, 2002), is adopted to maximize the
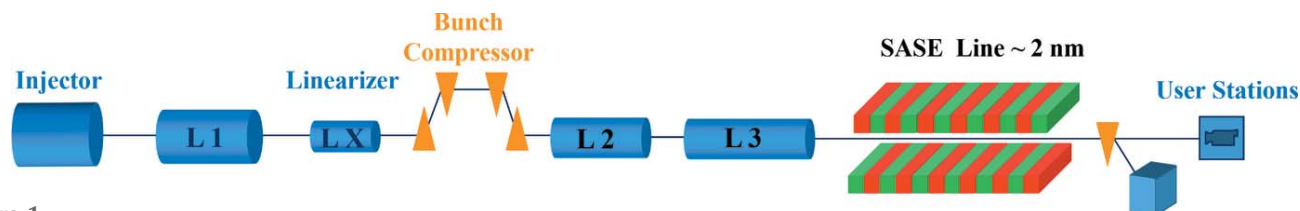
Figure 1
Layout of the SXFEL user facility linac and the SASE line.

beam energy chirp at SXFEL, and thus its radiation band-width.

Currently, the SXFEL user facility is under construction at the Shanghai Synchrotron Radiation Facility campus (Zhao *et al.*, 2017). In the SXFEL user facility, 500 pC electron bunches are generated and accelerated to 130 MeV at the S-band photo-injector and further accelerated by the linac. The main linac consists of three accelerating sections and two bunch compressors. The first S-band accelerating section (L1) is operated at off-crest to induce energy chirp in the bunch, and an X-band linearizer is used to linearize the energy chirp. The first magnetic chicane compresses the electron bunches at an energy of 256 MeV. The subsequent second and third C-band accelerating sections (L2, L3) increase the beam energy to 1.5 GeV. Another chicane lies between L2 and L3 to further compress the bunch. In the large-bandwidth operation mode of the SXFEL, the second magnetic chicane is supposed to be turned off in order to take advantage of strong longitudinal wakefields. The SXFEL has two undulator lines, *i.e.* a two-stage seeded FEL line to generate fully coherent 3 nm FEL radiation and a SASE line which is proposed to generate large-bandwidth radiation. In the SASE line, ten in-vacuum undulators with a 16 mm period and 4 m segment length are used. A schematic layout of the facility with a single-stage bunch compressor and SASE line is shown in Fig. 1. Well benchmarked codes are used to perform the start-to-end simulations of the SXFEL here. *ASTRA* (Flottmann *et al.*, 2003) is used to track electron bunches in the photo-injector. *ELEGANT* (Borland, 2000) is used for simulations of the main linac where collective effects are considered. Generations of the XFEL pulses in the undulator are simulated by *GENESIS* (Reiche *et al.*, 2007).

During optimization, the voltages and phases of the first S-band accelerating section, the X-band linearizer and the angle of the first bunch compressor are chosen as optimization variables. Constraints of these variables are set according to the corresponding hardware limits of the SXFEL, such as the voltage ranges of the RF structures. Optimization objectives include the current, slice energy spread and energy chirp, all of which are calculated by the parallel *ELEGANT* code with 10^5 macroparticles. An electron beam is divided into 40 slices for calculating these objectives. The current objective (I_{mean}) is defined as the average current of the 20 central slices. The slice energy spread objective (σ_{mean}) represents the average slice energy spread of these 40 slices. The beam energy chirp (C) is calculated by the absolute energy difference between the first and last slice. In order to avoid electron beams with poor current profiles and to decrease search areas, additional
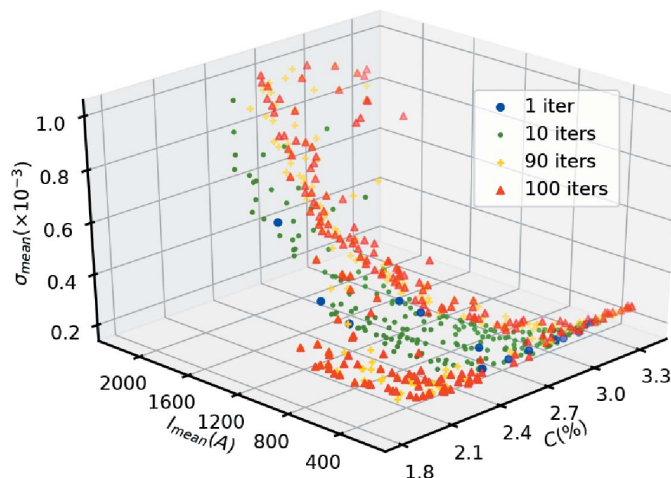

Figure 2
Pareto-optimal fronts at 1, 10, 90 and 100 iterations of the optimization with NSGA-II.

restrictions have been given during the optimization; for example, if the bunch charge in the central 20 slices is less than 70% of the total bunch charge, *i.e.* a poor current profile solution is given the worst fitness values.

The population size and number of iterations in the algorithm are set to 200 and 100, respectively. Fig. 2 depicts the Pareto-optimal fronts in 1, 10, 90 and 100 generations. The final Pareto-optimal front shows that when the current is between 700 and 1000 A, which is near the normal operation value in the SXFEL, the maximum energy chirp is 2.7%. Solutions with more than 3% energy chirp can be achieved when the current is less than 500 A or larger than 2000 A, but these are not suitable for FEL lasing. An acceptable solution from the Pareto front was chosen as an example for the following broadband XFEL-based XAS and XMCD experiment scheme. The beam energy chirp of the chosen solution is 2.51%, as shown in Fig. 3, and a quasi-uniform current profile with a 700 A peak current was ensured. The undulator gap was adjusted according to the required central wavelength. Fig. 4 plots the corresponding XFEL radiation profile and spectrum of an FEL pulse at the end of the undulator line. The final FEL pulse energy was 323 µJ, and the full bandwidth including a 2% cut was 4.4%, which is near the theoretical value of twice the energy chirp.

3. Principles and methods of highly efficient XMCD

As mentioned above, a transmission-based method was chosen for XMCD detection. Combining the energy spectra of
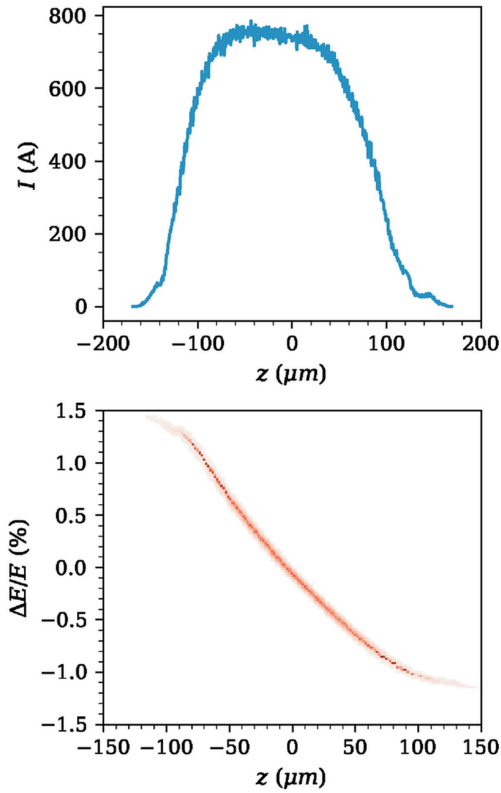
Figure 3
Current profile (top) and longitudinal phase space (bottom) of the chosen electron beam at the entrance of the undulator.

Figure 4
XFEL radiation profile (top) and spectrum (bottom) at the end of the undulator line for the chosen solution.

the incident and transmitted XFELs, the absorption cross-section can be obtained according to equation (2),

$$\sigma_{ab}(E) = -\ln\left[\frac{\Phi_{out}(E)/\eta_{det}(E)}{\Phi_{in}(E)/\eta_{det}(E)}\right]\frac{1}{N_v l}, \qquad (2)$$

where $\Phi_{out}(E)$ [$\Phi_{in}(E)$] represents the E_{ph} spectrum of the outgoing (incident) photons; $\eta_{det}(E)$ is the detection efficiency for the XFEL with a given energy E; N_v is the number density of an atom in the sample material, and l is the thickness of the target in the incident direction of the XFEL. The XMCD experiment requires simultaneous circular polarization and energy spectrum measurement, which can be achieved by using an e-TOF experiment (Zhang et al., 2017) based on the photoelectrons' angular distribution (Trzhaskovskaya et al., 2001; Manson & Starace, 1982) and drift time, respectively. To measure the E_{ph} spectrum, the relationship between E_{ph} and the photoelectron energies E_e is

$$E_{ph} = E_e + E_b = \frac{1}{2}m_e\left(\frac{L}{\Delta t}\right)^2 + E_b, \qquad (3)$$

where m_e is the electron's rest mass and E_b represents the binding energy of the shell originating the photoelectrons (Trzhaskovskaya et al., 2001). Thus, for an e-TOF instrument with a given drift length (L), the outgoing (or incident) E_{ph} spectrum can be derived from the photoelectrons' times of flight (Δt) according to equation (3).
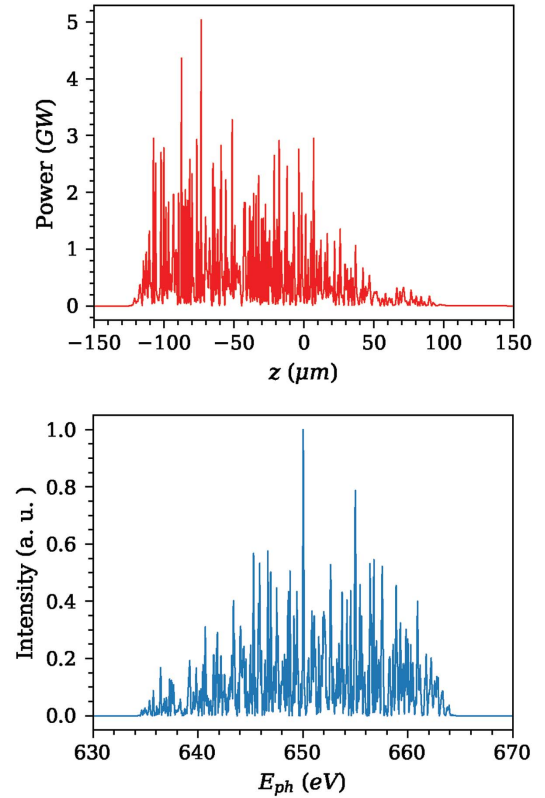
Under strong magnetic fields, electrons excited by fully circularly polarized photons have different transition probabilities due to their different spins, and thus a sample's absorption cross-section varies with the direction of circular polarization ($\mu = \pm$), the so-called XMCD phenomenon. Combining the cross-sections for the XFEL with two opposite circular polarization directions, the XMCD (defined as $\sigma_{\mu_+} - \sigma_{\mu_-}$) and XAS [defined as $(\sigma_{\mu_+} + \sigma_{\mu_-})/2$] can be obtained (Thole et al., 1992; Nesvizhskii et al., 2000). According to the famous sum rule (Thole et al., 1992), the orbital momentum L_z and spin momentum S_z are (Thole et al., 1992; Stöhr, 1999)

$$L_z \propto \Delta L_2 + \Delta L_3, \qquad (4)$$

$$S_z + \frac{7}{2}T_z \propto \Delta L_3 - 2\Delta L_2, \qquad (5)$$

where ΔL_2 (ΔL_3) represents the integration value of the edge L_2 (L_3) in the XMCD spectrum, and T_z is the magnetic dipole term related to anisotropic charge, which can be neglected with high crystal symmetries and small spin–orbit splitting (Stöhr & König, 1995; Nesvizhskii et al., 2000). The ratio of L_z to S_z (branching ratio, BR) is usually used to infer electronic structure (Nesvizhskii et al., 2000; Laguna-Marco et al., 2010; van der Laan, 1990) by equation (6),

$$BR = L_z/S_z = \frac{\Delta L_2 + \Delta L_3}{\Delta L_3 - 2\Delta L_2}. \qquad (6)$$

In order to evaluate the performance of the XMCD experiment, the relative deviation of BR will be used for further analysis. As in a recent time-resolved XMCD experiment, a pump laser was used to excite target atoms, and a fully circularly polarized XFEL pulse with a delay was used for measuring the absorption cross-section when atoms de-excited, from which critical microscopic properties such as electronic structure could be inferred (Higley *et al.*, 2016). By changing the pump–probe time interval, atomic de-excitation can be recorded instantaneously (Higley *et al.*, 2016).

The proposed experiment facilities are designed to contain four parts: the laser source, experimental system, detection system and electronics system. A block diagram of the experimental arrangement is shown in Fig. 5. The laser source provides broadband XFEL pulses which fluctuate from shot to shot. However, a steady energy spectrum can be obtained by superposing an E_{ph} spectrum with a proper number of pulses. Thus, two E_{ph} superposed spectra with sufficient pulses close to each other can be used to measure the absorption spectra. One is used for measuring incident spectra and the other can be used for measuring transmitted spectra after light passes through the sample. Then, the absorption cross-section for the XFEL with a given circular polarization can be derived according to equations (2), (4), (5) and (6). The experimental system is where the XFEL interacts with the target and is used to measure the E_{ph} spectrum by using the e-TOF instrument. After a short delay caused by the pump laser, which transfers target atoms to an excited state, a circularly polarized XFEL pulse interacts with the sample material. By changing the pump–probe delay and using enough pulses, the XMCD during the entire de-excitation process can be monitored. According to equation (2), spin and orbital magnetism, which are related to the electron state densities and spin directions at different de-excitation times, can be obtained. The electronics system contains a time-to-digital converter (TDC) and a waveform digitizer for pulse-shape sampling. Signal processing is described briefly below. Once photoelectrons reach the micro-channel plate electron detector, a signal is generated and sent to the discriminator. The TDC is triggered by a start signal from the XFEL source and stopped by a signal from the discriminator, recording the flight time of the earliest photoelectrons. Meanwhile, a waveform digitizer with a sampling interval is triggered to record the signal after a proper delay,

aiming to cover the whole spectrum. The sampled signal from the waveform digitizer is then analyzed online and decomposed to obtain the E_{ph} spectrum by deconvolution.

Generally, noise from phenomena such as XFEL beam fluctuation and photoelectron drift lead to lower quality deconvolutions. Compared with our previous research (Zhang *et al.*, 2017), an improved method using Wiener deconvolution (Wiener, 1949) has been used to retrieve E_{ph} from a signal pulse robustly, reducing the influence of the noise significantly. In the following, this method will be described. First, a digitized signal is adjusted by various time offsets, *e.g.* due to electronics cables and detector response delays. Second, the adjusted digitized signal is interpolated with a smaller time interval for signal deconvolution, because the sampling period is much greater than the real interval between two arrival photoelectrons. Finally, the Wiener algorithm is used to reconstruct the photoelectron spectrum from the signal pulse shape as described below.

The interpolated time-of-flight (TOF) signal shape $P(t)$ can be described by equation (7) in the time domain,

$$P(t) = S(t) * [N(t) * N_s(t)] + e(t), \qquad (7)$$

where $*$ represents the convolution operation; $S(t)$ is the pulse shape of an MCP detector for a single electron without delay; $N(t)$ is the theoretical flight time of a photoelectron from a photon with a given energy in the vacuum; $N_s(t)$ is the distribution of photoelectrons in the time domain (without an offset of the earliest flight time); $F(t)$ is the signal pulse shape for an impulse in the time domain, which can be described by the shape of a Log–Gaussian distribution (Zhang *et al.*, 2017); and $e(t)$ is an error term due to noise and statistical fluctuations. In the frequency domain, equation (7) can be written

$$P(f) = F(f) N(f) + e(f). \qquad (8)$$

According to the Wiener deconvolution algorithm, the estimated distribution of the theoretical TOF in vacuum $[\hat{N}(t)]$ can be obtained by applying a filter $W(f)$ to $P(f)$, which satisfies the relation as shown in equation (9),

$$\hat{N}(t) = \mathcal{F}^{-1}[W(f) P(f)], \qquad (9)$$

where $\mathcal{F}^{-1}$ represents the inverse Fourier transform. Analytically, an optimal $W(f)$ can be written (Wiener, 1949)
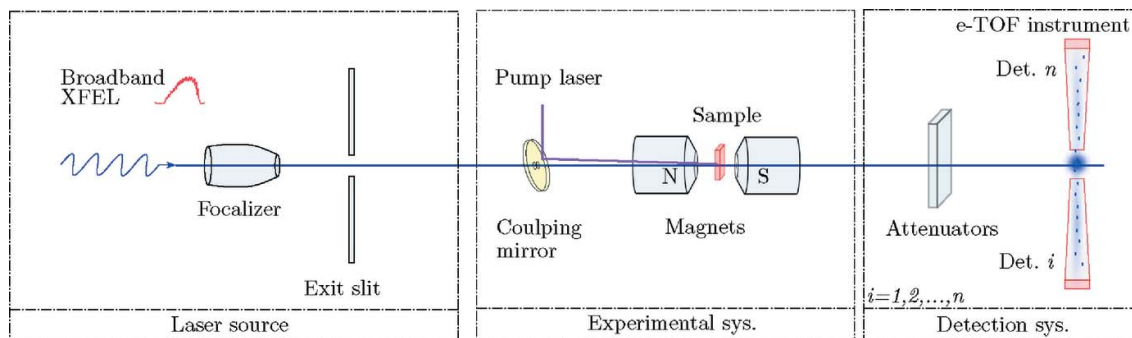

Figure 5
Block diagram of the experiment.

$$W(f) = \frac{F^*(f)}{|F(f)|^2 + |e(f)|^2/|N(f)|^2}. \tag{10}$$

From equation (10), the impulse response of a detection instrument (e-TOF) and the power spectrum of the signal-to-noise ratio should be known. The former can be measured using a conventional XFEL and monochromators, while the latter can be estimated by the local variance of the signal with a proper window, or by a known spectrum measured by another conventional spectrometer under similar conditions. Finally, the E_{ph} spectrum can be obtained from the estimated flight time $\hat{N}(t)$ according to equation (3).

Here, the detailed methodology is described. According to the experimental method described above, procedures include two stages: preparation and operation. The preparation stage aims to calibrate the e-TOF instrument. The XFEL source in its conventional mode (narrow bandwidth) and the monochromator were used to measure the average impulse response of the e-TOF instrument $F(t)$ and the detection efficiency $\eta_{det}(E_{ph})$, by choosing the proper number of energy points in the energy range and B-spline interpolation. The preparation stage is only performed once and is not required when samples are changed. The operation stage aims to measure the absorption cross-sections of circularly polarized photons in two polarization directions, and consists of the following steps. First, operational tuning of the broadband mode must be performed to modulate the XFEL to provide fully circularly polarized photons covering the entire energy range, both of which can be diagnosed by the e-TOF instrument simultaneously (Zhang et al., 2017). Second, the target must be placed into the experimental container with a proper magnetic field. By using sufficient XFEL pulses and setting a proper pump–probe delay, the electrons' time-of-flight signal shapes for the XFEL can then be recorded, which are then analyzed online and used to obtain the absorption spectrum E_{ph}. Third, the time-resolved absorption spectrum for XFEL must be measured when fully circularized in a particular direction by changing the pump–probe interval and repeating the second step. Then, the TOF signal must be recorded using the same number of XFEL pulses after removing the target, and the incident E_{ph} spectrum can be reconstructed accordingly. Combining with absorption spectrum in the third step, the corresponding time-resolved absorption cross-section can be obtained. Then, the time-resolved cross-section for another circular polarization direction is measured by reversing the circular polarization direction or, equivalently, the direction of the magnetic field (Stöhr, 1999). Finally, the XMCD and XAS spectra can be calculated according to the measured absorption spectra in the two circularly polarized directions. Furthermore, orbital and spin-magnetic properties can be calculated with equations (4) and (5).

4. Numerical modeling and sensitivity analysis

In order to clearly describe the proposed XAS/XMCD method driven by a broadband XFEL pulse, an example with an MnO sample is numerically illustrated based on the broad-
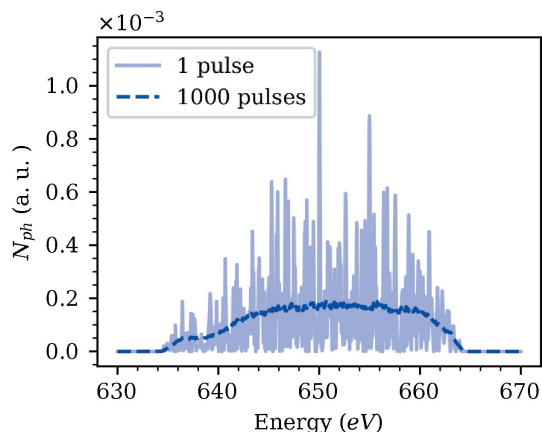
Figure 6
Superposed E_{ph} spectrum with different number of pulses.

bandwidth XFEL discussed in Section 2. We chose a solution from the optimization above to generate large energy-chirped electron bunches. The current profile and longitudinal phase space of the electron beam are shown in Fig. 3, and the power and energy spectra of a single broadband XFEL pulse are shown in Fig. 4. As mentioned above, considering the shot-to-shot fluctuation of the SASE pulse spectrum, a steady FEL spectrum can be obtained by superposing multiple SASE pulses, as shown in Fig. 6. The root-mean-square error (RMSE) was used to evaluate the stability and accuracy of the superposed FEL spectrum, defined as

$$\mathrm{RMSE} = \left[\left(E_{ph,st} - E_{ph} \right)^2 / n \right]^{1/2}, \tag{11}$$

where $E_{ph,st}$ represents the steady spectrum and n is the number of bins. For convenience, the superposed E_{ph} spectrum of 4000 pulses is regarded as a steady spectrum. The relationship between the RMSE and number of pulses (N_{ph}) is shown in Fig. 7, from which the RMSE of the spectrum superposed by 286 pulses was decreased to 5% compared with the E_{ph} spectrum of a pulse, suggesting that a potentially practical number of pulses is about 1000 pulses. Thus, the
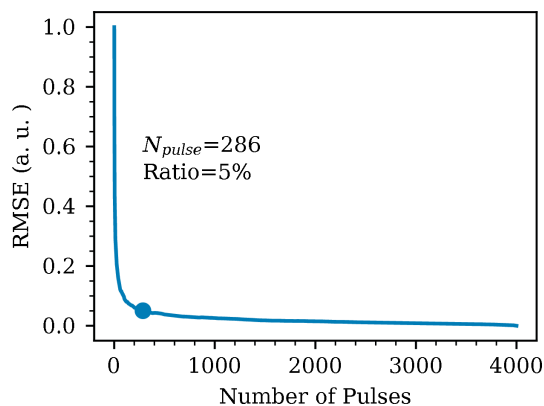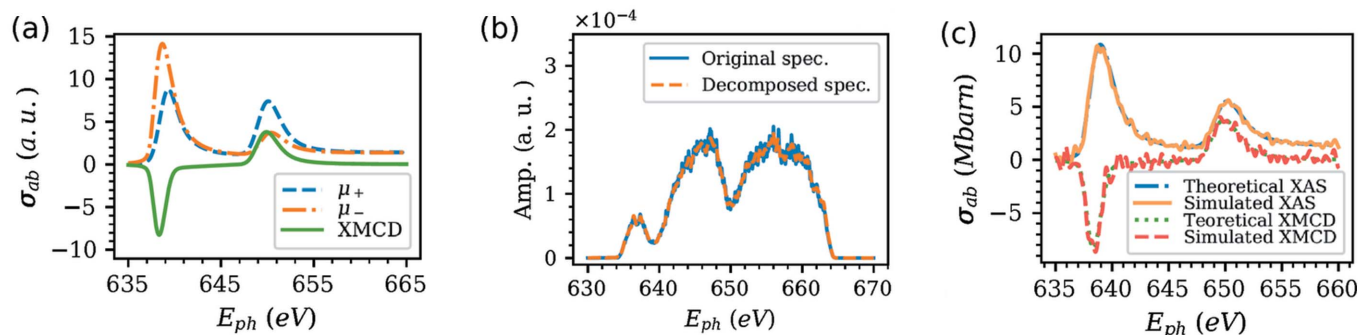
Figure 7
Relationship between the RMSE and number of XFEL pulses. The E_{ph} spectrum obtained with 4000 pulses is regarded as a steady spectrum.

Figure 8
Simulation results using our numerical model. (*a*) Simulated absorption cross-section of MnO. (*b*) Comparison of decomposed transmission E_{ph} and original simulated spectra. (*c*) Comparison of decomposed XMCD/XAS spectra with theoretical XMCD/XAS in Fig. 8(*a*).

number of pulses was set to 286 temporarily for this baseline calculation.

The calculation of the typical cross-section of MnO in the ground state for both left- and right-circularly polarized FELs was performed in the framework of *FDMNES* (Joly *et al.*, 2009). The MnO was in the ground state and the crystal space group was *Fm3m* ($a = b = c = 4.436$ Å and $\alpha = \beta = \gamma = 90°$). The magnetic field was in the z direction, perpendicular to the plane of the X-ray's circular polarization. Gaussian broadening ($\mu = 0.1$ eV, $\sigma = 0.05$ eV) and a uniform broadening of 0.8 eV due to complex energies were implemented to be consistent with the experimental absorption cross-section from the Shanghai Synchrotron Radiation Facility. Other influences such as self-absorption and birefringence were also taken into consideration. A typical dichroism cross-section calculation with the MnO sample is shown in Fig. 8(*a*), and is used to calculate the absorption spectrum for the demonstration of the experimental method.

As mentioned above, polarization diagnosis and energy spectrum measurement can be performed by using an e-TOF instrument, whose numerical model [in the framework of *Geant4* (Chauvie *et al.*, 2001)] has been designed thoroughly in our previous research (Zhang *et al.*, 2017). In this work, the numerical model and optimal design were reused for modeling and analysis. The enhancement of the e-TOF signal decomposition method described in equations (7)–(10) for E_{ph} measurement was implemented in this work. According to equation (2) and the description of the preparation stage, a measurement of the detection efficiency curve for different energies is required. In simulation, the detection efficiency was measured by using several XFEL pulses with high coherencies selected by the monochromator in conventional mode, whose energy was selected by using a Gaussian distribution with a standard deviation of 0.026 eV and a varied average energy.

Other critical parameters in the simulation are listed in Table 1. To evaluate the experimental performance, the RMSE of XMCD (or XAS) and the relative deviation of the branching ratio were used to evaluate statistical error and the measurement precision, respectively. Because of an MnO crystal's high symmetry and small spin–orbit splitting, the magnetic dipole term T_z can be neglected in BR calculation (Stöhr & König, 1995; Nesvizhskii *et al.*, 2000). The result of

Table 1
Critical parameters of the numerical model.

Parameters	Value	Description
L	400 mm	Drift length of photoelectrons
ΔT_s	50 ps	Sampling time interval
N_p	286	Number of XFEL pulses
d_m	1.58×10^{-7} g cm^{-2}	Mass thickness of the sample
Sample	MnO	Sample material
D	42 mm	Effective diameter of electron detectors
Gas	O_2	Target gas in the e-TOF instrument
E_b	539.43 eV	Binding energy of target gas

the simulation is shown in Fig. 8. The relative deviation of BR is 0.98% and the RMSE of the XMCD and XAS spectra reached 0.62 and 0.42, respectively, essentially satisfying the experimental requirements. Owing to the limited number of detected photoelectrons (about 9000 per detector per pulse) and low XFEL pulse repeating frequency (50 Hz), the influence of vacuum space-charge effects in detection can be ignored.

Multiple critical parameters can affect XMCD/XAS measurements, which prefer a steady superposed spectrum for incident and transmitted E_{ph} measurement and a high-precision pulse shape digitization. A steady superposed spectrum can be obtained by using sufficient XFEL pulses as mentioned previously. In addition, a high-precision pulse-shape digitization can be achieved with a small digitization interval and a long pulse time duration, which suggests the use of a long drift length. In the following, the influence of three critical parameters (the number of pulses, digitization interval and photoelectrons' drift lengths) on the experimental performance will be analyzed by changing each parameter value individually while holding others fixed at values listed in Table 1.

For a given number of pulses, large quantities of XFEL pulses can reduce the fluctuations of the electric field in undulators and statistical error due to the number of detected electrons. In order to determine the minimal XFEL shots, the relationship between the number of pulses and optimization objects were analyzed, with the result displayed in Fig. 9(*a*). The minimal number of pulses required for achieving the design goal (relative deviation of branch ratio ∼1%) is 200.
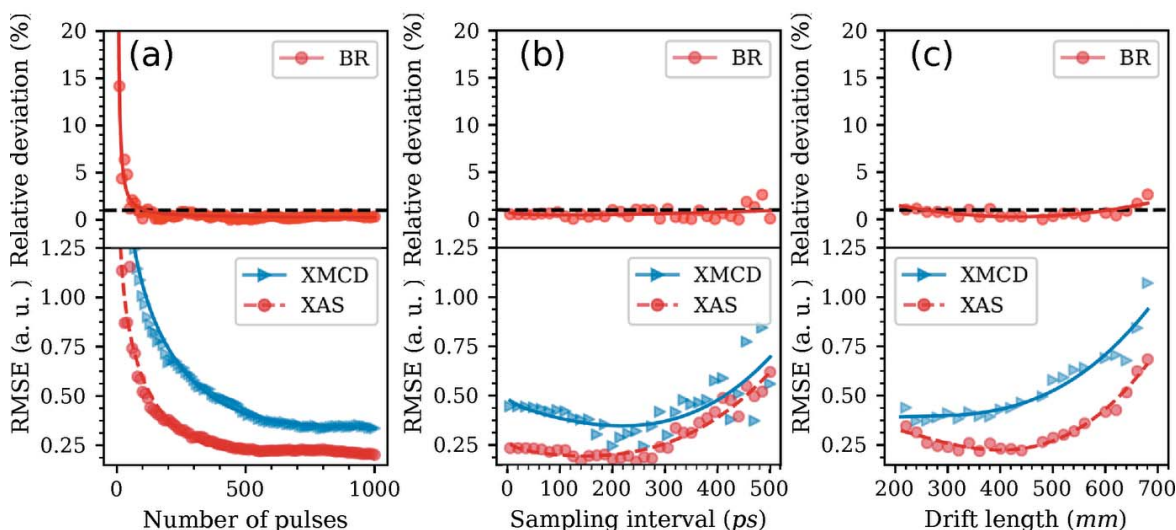
Figure 9
Sensitivity analysis of experimental performance with (*a*) different number of pulses, (*b*) different sampling interval and (*c*) different drift length.

However, to balance the RMSE value, 400 pulses were chosen as the optimized value.

For the sampling interval, a small digitization period is preferable for a precise e-TOF signal. However, smaller sampling intervals lead to a higher noise sensitivity, while larger sampling intervals produce inaccurate digitization. The related analysis is demonstrated in Fig. 9(*b*). From the simulation, the optimal sampling period is around 250 ps, where the RMSE is the smallest, while the relative deviation of the measured branch ratio changed little due to the smoothness of integration.

A long drift length is preferable, since it converts small energy intervals into measurable time intervals. However, a larger drift distance also induces larger statistical error and is more strongly influenced by the Earth's magnetic field. The influence of different drift lengths is shown in Fig. 9(*c*), wherein an optimal drift length of ∼450 mm with minimal RMSE is achieved while the branch ratio changes only a little.

By implementing the optimal design outlined above, a relative deviation of the BR was reduced to 0.79% and the RMSE values of 0.38 and 0.27 were achieved for the XMCD and XAS spectra, respectively. Since only 400 consecutive shots were needed, the experiment can be completed within tens of minutes with one or two machine adjustments.

5. Single-shot XAS/XMCD

Single-shot XAS/XMCD is extremely appealing for fast measurements when sample materials are too sensitive to allow numerous pulses. For a single pulse, the e-TOF spectrometer utilizes only a small fraction of photons. The electron yield is sufficient for E_{ph} diagnosis using a single shot but not for precise single-shot E_{ph} measurement. Grating spectrometers are capable of measuring the broadband spectrum of each pulse, due to the highest utilization efficiency of photons compared with an e-TOF spectrometer. By using gratings and beam diffraction techniques, it is possible to perform pulse-to-pulse time-resolved XAS measurement. Furthermore, the XMCD spectra can be obtained with at least two XFEL pulses and a reverse of the direction of the magnetic field.

The apparatus arrangement is shown in Fig. 10. Here, the e-TOF instrument is only used for monitoring circular polar-
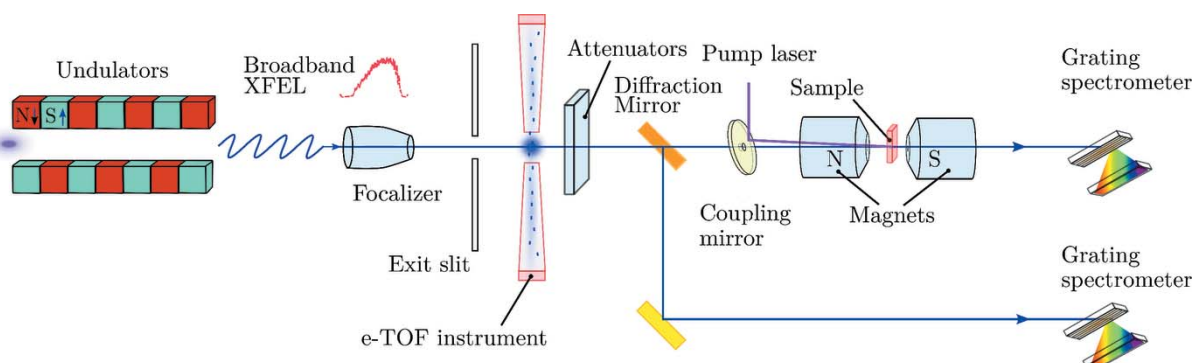

Figure 10
Apparatus blocks for the single-shot time-resolved absorption cross-section measurement.

ization and the E_{ph} spectrum, while the grating spectrometers are used for precise E_{ph} measurement with the XFEL. For a single shot, a circularly polarized broadband XFEL pulse with a pump–probe time delay was diffracted into two beams. In one, the XFEL interacts with the target sample and the transmitted absorption spectrum is calibrated precisely with the grating spectrometer. In the other, the XFEL is used for measuring the incident XFEL energy spectra. Combining these two spectra, the absorption cross-section in one polarization direction can be obtained. Then, the direction of the magnetic field is reversed and the absorption cross-section for another polarization direction can be measured along with the XMCD/XAS spectra.

In this way, a single shot with a proper pump–probe delay can be used for absorption spectrum measurement, and two pulses are required for XMCD and XAS spectra. A more complicated apparatus and optical path can be designed for future single-shot time-resolved XMCD/XAS spectra measurements, and requires simultaneous calibration of the absorption cross-section for the XFEL in two circular polarization directions. A possible design might inject an XFEL pulse from each of two sides of a sample in the same magnetic field and measure the transmission E_{ph} spectrum for each. Another possible design might use two pulses of multi-colored emitted XFEL light with a delay and a fast magnetic field reverse.

6. Conclusions

The feasibility of a highly efficient method for an XMCD experiment driven by broadband X-ray free-electron lasers has been proposed and numerically validated. To determine a satisfactory radiation bandwidth region and corresponding optimal operation parameters at the SXFEL user facility, an evolutionary multi-objective optimization algorithm was utilized to maximize the XFEL bandwidth. With hundreds of broadband FEL pulses (~ 30 eV) covering an entire absorption spectrum, and an e-TOF-based spectrometer and a robust e-TOF signal post-decomposition, XAS and XMCD can be measured with the same FEL machine in several minutes without resorting to tedious FEL wavelength tuning and other time-consuming machine operations.

The proposed method can be further improved to measure single-shot absorption spectra with X-ray diffraction splitting, dramatically reducing the risk of damage for highly radio-active-sensitive sample materials.

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